

ANNEXE A/ANNEX A

LISTE DES PARTICIPANTS/
LIST OF PARTICIPANTS

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(dans l'ordre alphabétique des noms français des États/
in the alphabetical order of the names in French of the States)

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II. ORGANISATIONS MEMBRES/MEMBER ORGANIZATIONS

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ORGANISATION AFRICAINE DE LA PROPRIÉTÉ INTELLECTUELLE (OAPI)/
AFRICAN INTELLECTUAL PROPERTY ORGANIZATION (OAPI)

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III. BUREAU/OFFICERS

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Secrétaire/Secretary:	Antonios FARASSOPOULOS (OMPI/WIPO)

IV. BUREAU INTERNATIONAL DE L'ORGANISATION MONDIALE DE LA
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Bureau du PCT (Traité de coopération en matière de brevets)/Office of the PCT (Patent Cooperation Treaty): Gary SMITH (directeur/Director); Mikhail MAKAROV (chef de la Section de la classification internationale des brevets/Head, International Patent Classification Section); Antonios FARASSOPOULOS (administrateur principal de la classification des brevets à la Section de la classification internationale des brevets/Senior Patent Classification Officer, International Patent Classification Section)

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[L'annexe B suit/
Annex B follows]